## CS305 Computer Architecture

S Integrated Circuit (IC) Technology: An Overview

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MSI
LSI- 104
VLSI
```

ULS/

Bhaskaran Raman

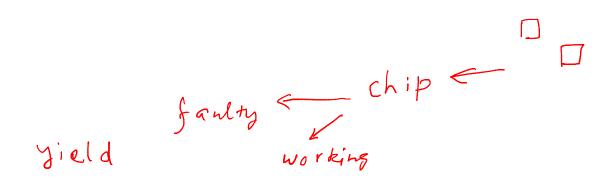
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The IC Manufacturing Process

conductors
insulators
transistors
Silicon



## IC Cost

$$Cost per die = \frac{Cost per wafer}{Dies per wafer \times yield}$$

Straightforward algebra

Dies per wafer 
$$\approx \frac{\text{Area of wafer}}{\text{Area of die}}$$

**Approximation** 

Yield = 
$$\frac{1}{[1 + (\text{Defects per area} \times \text{Area of die}/2)]^2}$$
 From experience

- Unit cost of chip decreases with volume of production
  - Fixed costs amortised: design, masks in chip manufacture
  - Tuning to improve yield

## **Limits to IC Density**

- Fundamental physical dimension limits
- Power consumption
  - ~ 2.6 cm<sup>2</sup>, 4 GHz Intel Core i7, 88W power
- Fan needed to sink the heat
- Frequency scaling employed